

Application No.	Applicant(s)							
09/832,687	HAMM ET AL.							
Examiner	Art Unit							
Seuna H Lee	2876							

ORIGINAL						CROSS REFERENCE(S)										
CLASS SUBCLASS				SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)										
356 328		356	305	326												
INTERNATIONAL CLASSIFICATION					250	208.1										
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Seung H Lee 9/3/2004 (Assistant Examiner) (Date))4 e)	SUPERVIS	MICHAEL G. ORY PATEN OLOGY CEN	T EXAN	MNER 100	Total Claims Allowed: 21						
(Yegal Instruments Examiner) (Date)					1/16/04 (Date)		pery Examiner	2	O.G. O.G. Print Claim(s) Print Fi							

Claims renumbered in the same order as presented by applicant								☐ CPA			☐ T.D.			☐ R.1.47					
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	2			32]		62			92	: 41		122			152			182
	3			33			63			93			123			153	γ •		183
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	6 7]		36]		66			96		-	126			156			186
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	15			45]		75]		105			135			165			195
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	26			56			86]		116			146			176			206
	27			57			87			117			147			177			207
	28			58			88			118			148			178			208
	29			59			89			119			149			179			209
	30			60			90			120			150			180			210